

# Single-Bit Hologram

A hologram is a holographically recorded object. When two coherent light beams intersect each other, an interference pattern is generated. If this occurs in a material that is sensitive to light intensities greater than a certain exposure threshold, the interference pattern is recorded in the material as a modulation of the refractive index. Such a material is called a holographic material and the process of recording is called holographic recording. When one of the two light beams is originally scattered by an object before entering the holographic material, the beam is called the object beam while the other beam is called the reference beam. In this case, the recorded hologram also contains the information about the scattering object. Now, if the hologram is illuminated by the reference beam alone in the same optical setup, the object beam will be regenerated from the holographic material. This process is called the holographic retrieval. This concept is depicted in Figure 1.

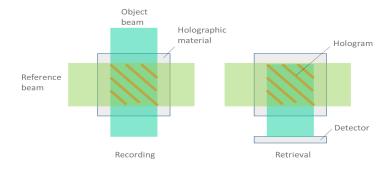


Figure 1: Holographic recording and retrieval.

# Model Definition

In this model, the simplest example is chosen, in which the object beam has the same profile as the reference beam. The reference beam enters a holographic material from the left boundary while the object beam enters it from the top boundary. In the recording process, the two beams cross at 90 degree angle in the material and make interference fringes tilted at 45 degrees. For intensities above a certain exposure threshold, a refractive index modulation is induced in the holographic material on top of the constant background refractive index. In the retrieval, only the reference beam illuminates the hologram. Then this beam is partially transmitted and partially reflected off by the

hologram, which regenerates the object beam. You can say that the hologram is working as a volume Bragg grating satisfying the Bragg condition for the reference beam.

# Results and Discussion

Figure 2 shows the electric field distribution during the recording phase. Notice that the intensity pattern in the rightmost figure shows diagonal stripes that result in the striped refractive index modulation, shown in Figure 3

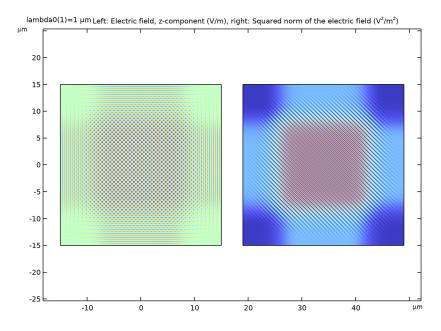


Figure 2: Electric field distribution during recording. The left figure show the z-component of the electric field, whereas the right figure shows the squared norm of the electric field.

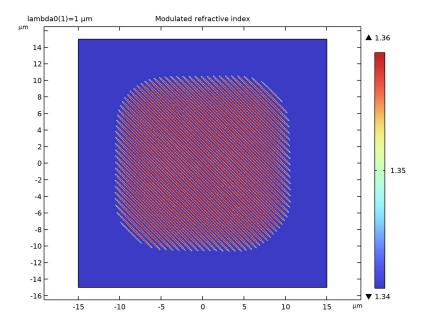


Figure 3: The refractive index distribution.

Figure 4 shows the intensity distribution across a cross section of the beam. The red line indicates the exposure threshold level for the holographic material. Notice that the refractive index modulation in Figure 5 starts at the location where the threshold level

intersects the intensity distribution. In the wings of the beam, the intensity level is too low to induce any refractive index modulation.

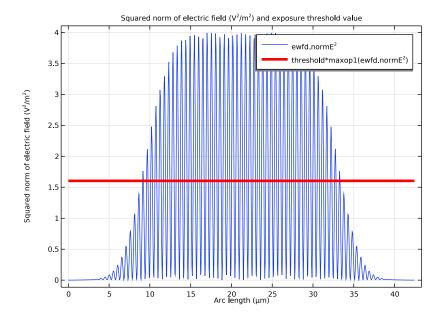


Figure 4: The electric field distribution during recording. The blue curve shows the squared electric field norm, whereas the red line indicates the exposure threshold for the holographic material.

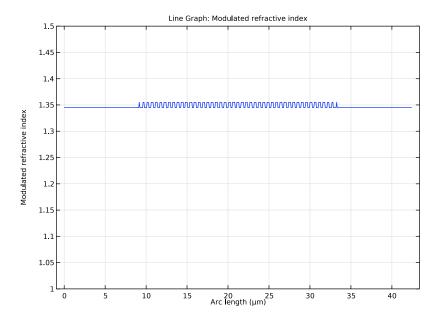


Figure 5: The induced refractive index modulation.

Finally, Figure 6 shows the electric field distribution during the retrieval phase. Here, only the reference beam is incident. However, as it is scattered by the induced refractive index grating, the object beam is regenerated and propagates toward the bottom of the figure.

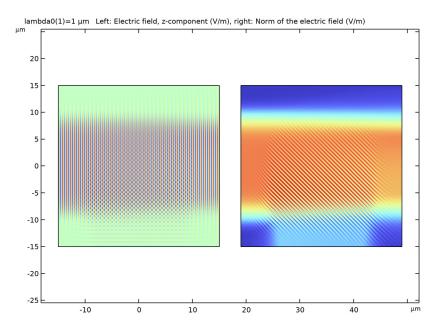


Figure 6: The electric field distribution during the retrieval phase. The left figure shows the zcomponent of the electric field, whereas the right figure shows the norm of the electric field.

Application Library path: Wave\_Optics\_Module/Gratings\_and\_Metamaterials/ single\_bit\_hologram

# Modeling Instructions

From the File menu, choose New.

#### NEW

In the New window, click Model Wizard.

# MODEL WIZARD

I In the Model Wizard window, click **2** 2D.

- 2 In the Select Physics tree, select Optics>Wave Optics>Electromagnetic Waves, Frequency Domain (ewfd).
- 3 Click Add.
- 4 Click Study.
- 5 In the Select Study tree, select Preset Studies for Selected Physics Interfaces> Wavelength Domain.
- 6 Click **Done**.

#### **GLOBAL DEFINITIONS**

Start by loading the parameters that defines the model geometry and material properties.

# Parameters 1

- I In the Model Builder window, under Global Definitions click Parameters I.
- 2 In the Settings window for Parameters, locate the Parameters section.
- 3 Click Load from File.
- **4** Browse to the model's Application Libraries folder and double-click the file single bit hologram parameters.txt.

#### **GEOMETRY I**

The simulation domain consists of a rectangle with width L and height H.

- I In the Model Builder window, under Component I (compl) click Geometry I.
- 2 In the Settings window for Geometry, locate the Units section.
- 3 From the Length unit list, choose µm.

Rectangle I (rI)

- I In the Geometry toolbar, click Rectangle.
- 2 In the Settings window for Rectangle, locate the Size and Shape section.
- 3 In the Width text field, type L.
- 4 In the **Height** text field, type H.
- 5 Locate the Position section. From the Base list, choose Center.
- 6 Click **Build All Objects**.

#### MATERIALS

Material I (mat I)

- I In the Model Builder window, under Component I (compl) right-click Materials and choose Blank Material.
- 2 In the Settings window for Material, locate the Material Contents section.
- 3 In the table, enter the following settings:

Property	Variable	Value	Unit	Property group
Refractive index, real part	n_iso ; nii = n_iso, nij = 0	n1	I	Refractive index
Refractive index, imaginary part	ki_iso ; kiii = ki_iso, kiij = 0	0	I	Refractive index

#### DEFINITIONS

A maximum operator will be used later when defining the refractive index variation of the hologram.

Maximum I (maxop I)

- I In the Definitions toolbar, click Nonlocal Couplings and choose Maximum.
- 2 Select Domain 1 only.

Refractive Index During Recording

Now, define the refractive indices that will be used for the recording phase and the retrieval phase. This variable will later define the refractive index for the material. In the study steps, you later define which of the two refractive index variables that will be used for the different phases.

- I In the Model Builder window, right-click Definitions and choose Variables.
- 2 In the Settings window for Variables, type Refractive Index During Recording in the Label text field.
- **3** Locate the **Variables** section. In the table, enter the following settings:

Name	Expression	Unit	Description
n	n1		Background refractive index

4 Right-click Refractive Index During Recording and choose Duplicate.

# Modulated Refractive Index

- I In the Model Builder window, under Component I (compl)>Definitions click Refractive Index During Recording 1.
- 2 In the Settings window for Variables, type Modulated Refractive Index in the Label text field.
- **3** Locate the **Variables** section. In the table, enter the following settings:

Name	Expression	Unit	Description
n_mod	<pre>n1+dn*(((ewfd.normE/ maxop1(ewfd.normE))^2&gt; threshold)-0.5)</pre>		Modulated refractive index

# Refractive Index During Retrieval

- I In the Model Builder window, right-click Definitions and choose Variables.
- 2 In the Settings window for Variables, type Refractive Index During Retrieval in the Label text field.
- **3** Locate the **Variables** section. In the table, enter the following settings:

Name	Expression	Unit	Description
n	<pre>withsol('sol2',n1+dn* (((ewfd.normE/ maxop1(ewfd.normE))^2&gt; threshold)-0.5))</pre>		Background refractive index

The withsol operator allows you to use expressions from a previous solution. In this case, it is the solution from the first study step, here denoted so12, that will be used for defining the refractive index distribution during the second study step.

#### MATERIALS

Material I (mat I)

- I In the Model Builder window, under Component I (compl)>Materials click Material I (mat I).
- 2 In the Settings window for Material, locate the Material Contents section.

**3** In the table, enter the following settings:

Property	Variable	Value	Unit	Property group
Refractive index, real part	n_iso ; nii = n_iso, nij = 0	n	I	Refractive index
Refractive index, imaginary part	ki_iso ; kiii = ki_iso, kiij = 0	0	I	Refractive index

# ELECTROMAGNETIC WAVES, FREQUENCY DOMAIN (EWFD)

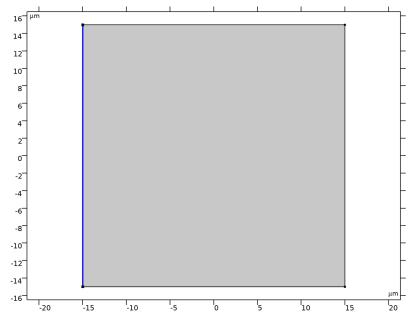
As the same study will include both the study step for the recording of the hologram and the study step for the retrieval of the object beam, all features required for both study steps will be added to the physics in the next step. Later on, the physics trees will be modified in the study step settings.

- I In the Model Builder window, under Component I (compl) click Electromagnetic Waves, Frequency Domain (ewfd).
- 2 In the Settings window for Electromagnetic Waves, Frequency Domain, locate the Components section.
- 3 From the Electric field components solved for list, choose Out-of-plane vector.

Reference Scattering Boundary Condition

- I In the Physics toolbar, click Boundaries and choose Scattering Boundary Condition.
- 2 In the Settings window for Scattering Boundary Condition, type Reference Scattering Boundary Condition in the Label text field.

**3** Select Boundary 1 only.



- 4 Locate the Scattering Boundary Condition section. From the Incident field list, choose Wave given by E field.
- **5** Specify the  $\mathbf{E}_0$  vector as

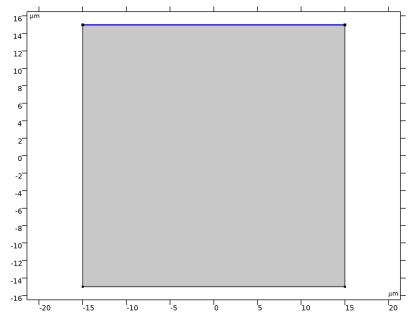
	_
0	x
0	у
exp(-(y/w_r)^6)	z

This defines the input electric field for the reference beam.

Object Scattering Boundary Condition

- I In the Physics toolbar, click Boundaries and choose Scattering Boundary Condition.
- 2 In the Settings window for Scattering Boundary Condition, type Object Scattering Boundary Condition in the Label text field.

**3** Select Boundary 3 only.



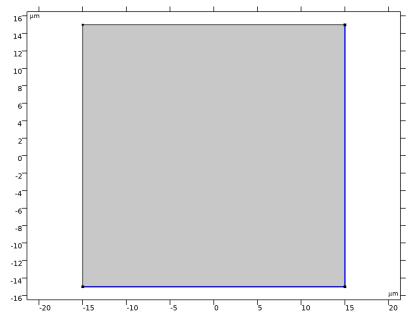
- 4 Locate the Scattering Boundary Condition section. From the Incident field list, choose Wave given by E field.
- **5** Specify the  $\mathbf{E}_0$  vector as

0	x
0	у
exp(-x^6/w_o^6)	z

Recording Scattering Boundary Condition

- I In the Physics toolbar, click Boundaries and choose Scattering Boundary Condition.
- 2 In the Settings window for Scattering Boundary Condition, type Recording Scattering Boundary Condition in the Label text field.

**3** Select Boundaries 2 and 4 only.

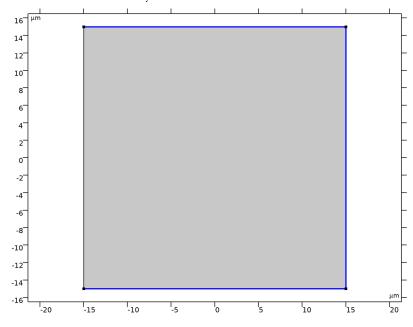


4 Right-click Recording Scattering Boundary Condition and choose Duplicate.

Retrieval Scattering Boundary Condition

- I In the Model Builder window, under Component I (compl)>Electromagnetic Waves, Frequency Domain (ewfd) click Recording Scattering Boundary Condition 1.
- 2 In the Settings window for Scattering Boundary Condition, type Retrieval Scattering Boundary Condition in the Label text field.

**3** Select Boundaries 2–4 only.



# MESH I

# Free Triangular 1

Set the maximum mesh element size to be one tenth of the material wavelength.

In the Mesh toolbar, click Free Triangular.

# Size

- I In the Model Builder window, click Size.
- 2 In the Settings window for Size, locate the Element Size section.
- 3 Click the **Custom** button.
- 4 Locate the Element Size Parameters section. In the Maximum element size text field, type w10/n1/10.

#### STUDY I

Now, define the two study steps.

#### Recording

- I In the Model Builder window, under Study I click Step I: Wavelength Domain.
- 2 In the Settings window for Wavelength Domain, type Recording in the Label text field.

- 3 Locate the Study Settings section. In the Wavelengths text field, type w10.
- 4 Locate the Physics and Variables Selection section. Select the Modify model configuration for study step check box.
- 5 In the tree, select Component I (compl)>Definitions>Refractive Index During Retrieval.
- 6 Right-click and choose Disable.
- 7 In the tree, select Component I (compl)>Electromagnetic Waves, Frequency Domain (ewfd)>Retrieval Scattering Boundary Condition.
- 8 Right-click and choose Disable.

#### Steb 1: Recording

Right-click Step 1: Recording and choose Duplicate.

#### Retrieval

- I In the Model Builder window, under Study I click Step 2: Recording I.
- 2 In the Settings window for Wavelength Domain, type Retrieval in the Label text field.
- 3 Locate the Physics and Variables Selection section. In the tree, select Component I (compl)>Definitions>Refractive Index During Recording.
- 4 Right-click and choose **Disable**.
- 5 In the tree, select Component I (compl)>Definitions>Refractive Index During Retrieval.
- **6** Right-click and choose **Enable**.
- 7 In the tree, select Component I (compl)>Electromagnetic Waves, Frequency Domain (ewfd)>Recording Scattering Boundary Condition.
- 8 Right-click and choose **Disable**.
- 9 In the tree, select Component I (compl)>Electromagnetic Waves, Frequency Domain (ewfd)>Retrieval Scattering Boundary Condition.
- 10 Right-click and choose Enable.

Solution I (soll)

Before clicking Compute, add a Solution Store, after the node Stationary Solver I, to store the solution from the first study step.

- I In the Study toolbar, click Show Default Solver. Move the node Solution Store I to be located between Stationary Solver I and Compile Equations: Retrieval.
- 2 Right-click Solution I (soll) and choose Other>Solution Store.
- 3 In the Study toolbar, click **Compute**.

#### RESULTS

#### Recording

Modify the default plot to show the interference between the reference beam and the object beam, by displaying the electric field and the square of the norm of the electric field.

- I In the Settings window for 2D Plot Group, locate the Data section.
- 2 From the Dataset list, choose Study I/Solution Store I (sol2). This selects the dataset for the first study step.>
- 3 In the Label text field, type Recording.

# Surface I

- I In the Model Builder window, expand the Recording node, then click Surface I.
- 2 In the Settings window for Surface, locate the Expression section.
- 3 In the Expression text field, type ewfd. Ez.
- 4 Locate the Coloring and Style section. Clear the Color legend check box.
- **5** Right-click **Surface I** and choose **Duplicate**.

# Surface 2

- I In the Model Builder window, click Surface 2.
- 2 In the Settings window for Surface, locate the Expression section.
- 3 In the Expression text field, type ewfd.normE^2.

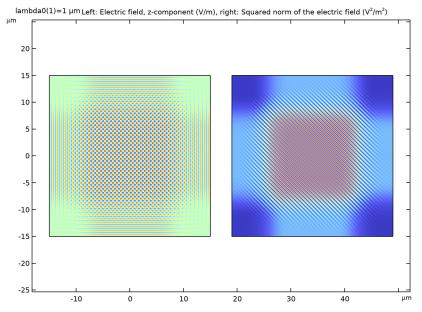
#### Translation 1

- I Right-click Surface 2 and choose Translation.
- 2 In the Settings window for Translation, locate the Translation section.
- 3 In the x text field, type 34.

#### Recording

- I In the Model Builder window, under Results click Recording.
- 2 In the Settings window for 2D Plot Group, click to expand the Title section.
- 3 From the Title type list, choose Manual.
- 4 In the Title text area, type Left: Electric field, z-component (V/m), right: Squared norm of the electric field (V<sup>2</sup>/m<sup>2</sup>).
- 5 In the **Recording** toolbar, click Plot.

6 Click the **Zoom Extents** button in the **Graphics** toolbar.



Now, duplicate this plot group to create a plot of the modulated refractive index.

7 Right-click Results>Recording and choose Duplicate.

# Surface 2

- I In the Model Builder window, expand the Recording I node.
- 2 Right-click Surface 2 and choose Delete.

# Modulated Refractive Index

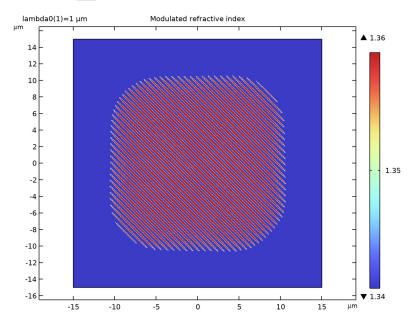
- I In the Model Builder window, under Results click Recording I.
- 2 In the Settings window for 2D Plot Group, type Modulated Refractive Index in the Label text field.
- 3 Locate the Title section. In the Title text area, type Modulated refractive index.

# Surface I

- I In the Model Builder window, click Surface I.
- 2 In the Settings window for Surface, click Replace Expression in the upper-right corner of the Expression section. From the menu, choose Component I (compl)>Definitions> Variables>n\_mod - Modulated refractive index.
- 3 Locate the Coloring and Style section. Select the Color legend check box.

# Modulated Refractive Index

- I In the Model Builder window, click Modulated Refractive Index.
- 2 In the Settings window for 2D Plot Group, locate the Color Legend section.
- 3 Select the Show maximum and minimum values check box.
- 4 In the Modulated Refractive Index toolbar, click Plot.
- 5 Click the **Zoom Extents** button in the **Graphics** toolbar.



# Cut Line 2D I

- I In the Results toolbar, click Cut Line 2D.
- 2 In the Settings window for Cut Line 2D, locate the Data section.
- 3 From the Dataset list, choose Study I/Solution Store I (sol2).
- 4 Locate the Line Data section. In row Point 1, set X to -L/2.
- 5 In row Point 1, set Y to -H/2.
- 6 In row Point 2, set X to L/2.
- 7 In row Point 2, set Y to H/2.

Squared Norm of the Electric Field

I In the Results toolbar, click  $\sim$  ID Plot Group.

- 2 In the Settings window for ID Plot Group, type Squared Norm of the Electric Field in the **Label** text field.
- 3 Locate the Data section. From the Dataset list, choose Cut Line 2D 1.

Line Graph 1

- I Right-click Squared Norm of the Electric Field and choose Line Graph.
- 2 In the Settings window for Line Graph, locate the y-Axis Data section.
- 3 In the Expression text field, type ewfd.normE^2.
- 4 Click to expand the **Legends** section. Select the **Show legends** check box.
- 5 From the Legends list, choose Manual.
- **6** In the table, enter the following settings:

# Legends ewfd.normE<sup>2</sup>

7 Right-click Line Graph I and choose Duplicate.

Line Graph 2

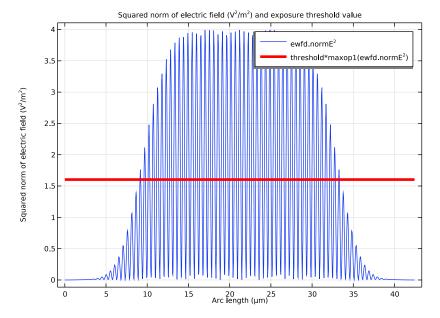
- I In the Model Builder window, click Line Graph 2.
- 2 In the Settings window for Line Graph, locate the y-Axis Data section.
- 3 In the Expression text field, type threshold\*maxop1(ewfd.normE^2).
- 4 Click to expand the Coloring and Style section. From the Color list, choose Red.
- **5** From the **Width** list, choose **4**.
- **6** Locate the **Legends** section. In the table, enter the following settings:

# Legends threshold\*maxop1(ewfd.normE<sup>2</sup>)

Squared Norm of the Electric Field

- I In the Model Builder window, click Squared Norm of the Electric Field.
- 2 In the Settings window for ID Plot Group, click to expand the Title section.
- 3 From the Title type list, choose Manual.
- 4 In the Title text area, type Squared norm of electric field (V<sup>2</sup>/ m<sup>2</sup>) and exposure threshold value.
- 5 Locate the **Plot Settings** section.
- 6 Select the y-axis label check box. In the associated text field, type Squared norm of electric field (V<sup>2</sup>/m<sup>2</sup>).

7 In the Squared Norm of the Electric Field toolbar, click Plot.



Modulated Refractive Index Line Plot

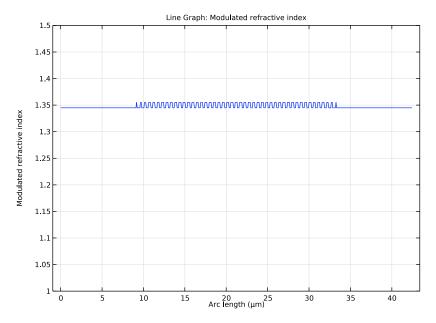
- I In the Home toolbar, click **Add Plot Group** and choose ID Plot Group.
- 2 In the Settings window for ID Plot Group, type Modulated Refractive Index Line Plot in the Label text field.
- 3 Locate the Data section. From the Dataset list, choose Cut Line 2D 1.

# Line Graph 1

- I Right-click Modulated Refractive Index Line Plot and choose Line Graph.
- 2 In the Settings window for Line Graph, click Replace Expression in the upper-right corner of the y-Axis Data section. From the menu, choose Component I (compl)>Definitions> Variables>n\_mod - Modulated refractive index.

# Modulated Refractive Index Line Plot

- I In the Model Builder window, click Modulated Refractive Index Line Plot.
- 2 In the Settings window for ID Plot Group, locate the Axis section.
- 3 Select the Manual axis limits check box.
- 4 In the y minimum text field, type 1.
- 5 In the y maximum text field, type 1.5.



# Recording

In the Model Builder window, right-click Recording and choose Duplicate.

# Retrieval (Reference Only)

- I In the Model Builder window, under Results click Recording I.
- 2 In the Settings window for 2D Plot Group, type Retrieval (Reference Only) in the Label text field.
- 3 Locate the Data section. From the Dataset list, choose Study I/Solution I (soll).
- 4 Locate the Title section. In the Title text area, type Left: Electric field, zcomponent (V/m), right: Norm of the electric field (V/m).

#### Surface 2

- I In the Model Builder window, expand the Retrieval (Reference Only) node, then click Surface 2.
- 2 In the Settings window for Surface, locate the Expression section.
- 3 In the Expression text field, type ewfd.normE.
- 4 In the Retrieval (Reference Only) toolbar, click on Plot.

# 5 Click the **Zoom Extents** button in the **Graphics** toolbar.

